

Notice of References Cited	Application/Control No. 10/676,591	Applicant(s)/Patent Under Reexamination FLETCHER, DEAN H.	
	Examiner Seung H. Lee	Art Unit 2876	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,347,742	02-2002	Winarski et al.	235/462.35
	B	US-6,374,145	04-2002	Lignoul, Mark	700/17
	C	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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